

RoHS Compliant Product
 A suffix of "-C" specifies halogen & lead-free

DESCRIPTION

The GM3055 provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness. The SOT-89 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

FEATURES

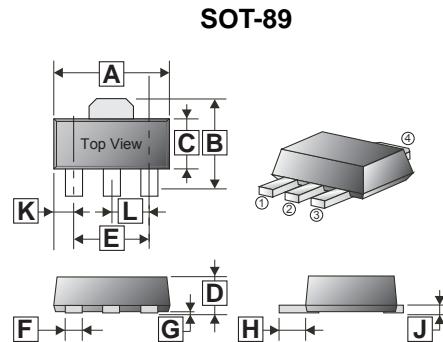
- Fast Switching
- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Simple Drive Requirement

MARKING

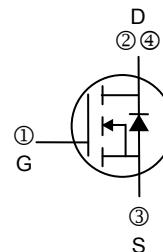


PACKAGE INFORMATION

Package	MPQ	Leader Size
SOT-89	1K	7 inch



REF.	Millimeter		REF.	Millimeter	
	Min.	Max.		Min.	Max.
A	4.40	4.60	G	-	-
B	4.05	4.25	H	0.89	1.20
C	2.40	2.60	J	0.35	0.41
D	1.40	1.60	K	0.70	0.80
E	3.00	REF.	L	1.50	REF.
F	0.40	0.52			



ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current ¹	I_D	5.8	A
$T_A = 70^\circ\text{C}$		4.7	A
Pulsed Drain Current ²	I_{DM}	30	A
Power Dissipation ³	P_D	1.5	W
Linear Derating Factor		0.0118	$^\circ\text{C} / \text{W}$
Operating Junction & Storage Temperature	T_J, T_{STG}	-55~150	$^\circ\text{C}$
Thermal Resistance Rating			
Thermal Resistance Junction-Ambient ¹ (Max.)	$R_{\theta JA}$	85	$^\circ\text{C} / \text{W}$
Thermal Resistance Junction-Case ¹ (Max.)	$R_{\theta JC}$	30	$^\circ\text{C} / \text{W}$

ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	BV_{DSS}	30	-	-	V	$\text{V}_{GS}=0$, $I_D=250\mu\text{A}$
Breakdown Voltage Temperature Coefficient	$\Delta \text{BV}_{DSS} / \Delta T_J$	-	0.021	-	V / °C	Reference to 25°C, $I_D=1\text{mA}$
Gate Threshold Voltage	$\text{V}_{GS(\text{th})}$	1.2	-	2.5	V	$\text{V}_{DS}=\text{V}_{GS}$, $I_D=250\mu\text{A}$
Gate-Source Leakage Current	I_{GSS}	-	-	±100	nA	$\text{V}_{GS}= \pm 20\text{V}$
Drain-Source Leakage Current	I_{DSS}	-	-	1	μA	$\text{V}_{DS}=24\text{V}$, $\text{V}_{GS}=0$
		-	-	5		$\text{V}_{DS}=24\text{V}$, $\text{V}_{GS}=0$
Static Drain-Source On-Resistance ²	$R_{DS(\text{ON})}$	-	-	28	mΩ	$\text{V}_{GS}=10\text{V}$, $I_D=5\text{A}$
		-	-	40		$\text{V}_{GS}=4.5\text{V}$, $I_D=4\text{A}$
Total Gate Charge ²	Q_g	-	6	8.4	nC	$I_D=5\text{A}$ $\text{V}_{DS}=15\text{V}$ $\text{V}_{GS}=4.5\text{V}$
Gate-Source Charge	Q_{gs}	-	2.5	3.5		
Gate-Drain ("Miller") Charge	Q_{gd}	-	2.1	2.9		
Turn-on Delay Time ²	$T_{d(on)}$	-	2.4	4.8	nS	$\text{V}_{DD}=15\text{V}$ $I_D=5\text{A}$ $\text{V}_{GS}=10\text{V}$ $R_G=3.3\Omega$ $R_D=1.9\Omega$
Rise Time	T_r	-	7.8	14		
Turn-off Delay Time	$T_{d(off)}$	-	22	44		
Fall Time	T_f	-	4	8		
Input Capacitance	C_{iss}	-	572	800	pF	$\text{V}_{GS}=0$ $\text{V}_{DS}=15\text{V}$ $f=1.0\text{ MHz}$
Output Capacitance	C_{oss}	-	81	112		
Reverse Transfer Capacitance	C_{rss}	-	65	91		
Source-Drain Diode						
Forward On Voltage ²	V_{SD}	-	-	1.2	V	$I_S=3\text{A}$, $\text{V}_{GS}=0$, $T_J=25^\circ\text{C}$
Continuous Source Current(Body Diode) ^{1,4}	I_S	-	-	5.8	A	$\text{V}_D=\text{V}_G=0$, $\text{V}_S=1.2\text{V}$
Pulsed Source Current(Body Diode) ^{2,4}	I_{SM}	-	-	30	A	

Notes:

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
2. The data tested by pulsed, pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$
3. The power dissipation is limited by 150°C junction temperature
4. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

CHARACTERISTIC CURVES

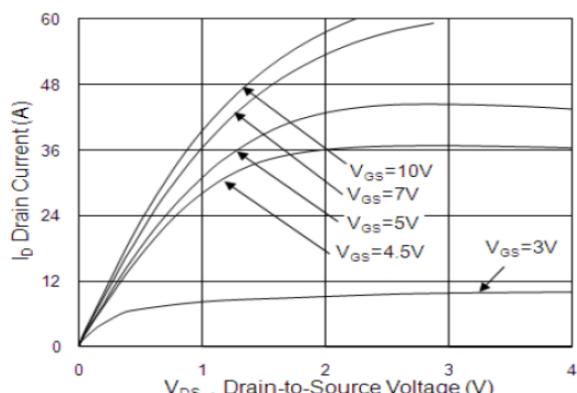


Fig.1 Typical Output Characteristics

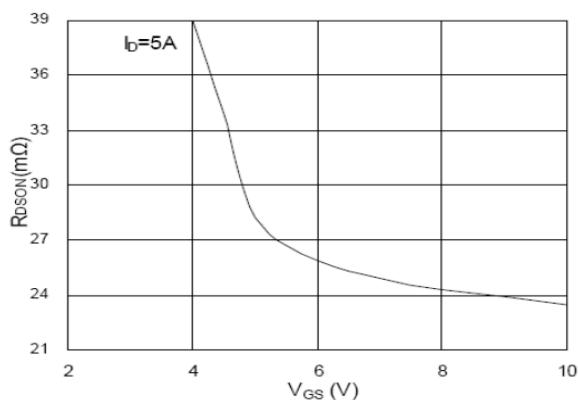


Fig.2 On-Resistance vs. G-S Voltage

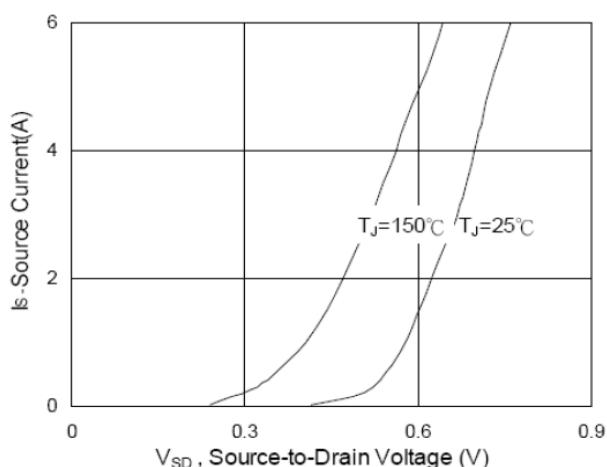


Fig.3 Forward Characteristics Of Reverse

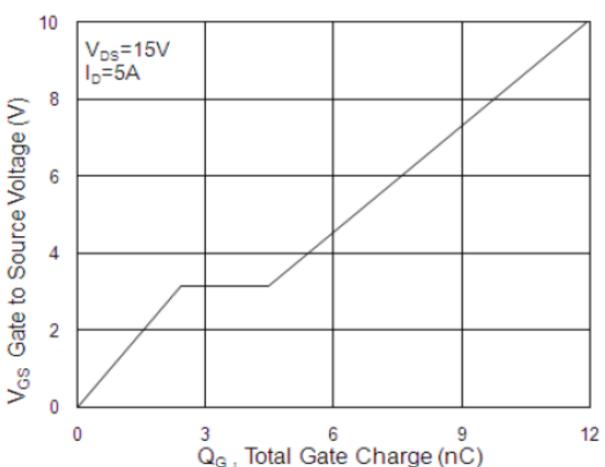


Fig.4 Gate-Charge Characteristics

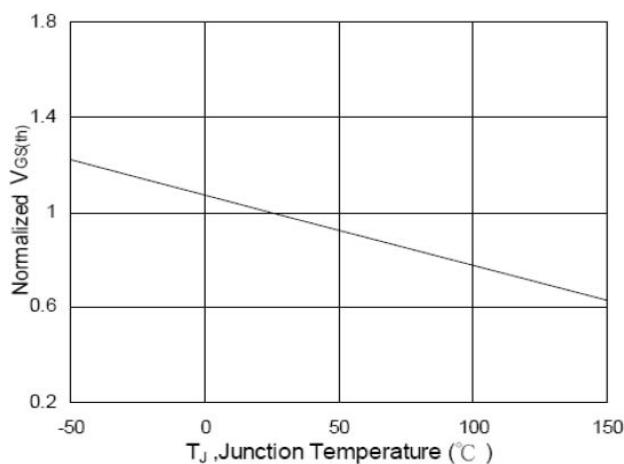


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

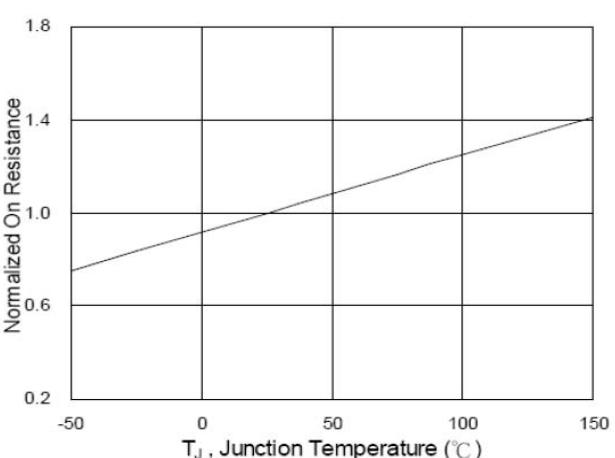


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

CHARACTERISTIC CURVES

